TOSHIBA Field Effect Transistor Silicon N, P Channel MOS Type (P Channel U-MOS IV/N Channel U-MOS III)

TPC8405

Lithium Ion Secondary Battery Applications Portable Equipment Applications Notebook PC Applications

Low drain-source ON resistance : P Channel RDS (ON) = 25 m Ω (typ.)

N Channel RDS (ON) = $20 \text{ m}\Omega$ (typ.)

High forward transfer admittance : P Channel $|Y_{fs}| = 12S$ (typ.) N Channel $|Y_{fs}| = 14S$ (typ.)

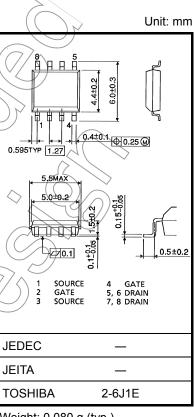
Low leakage current : P Channel IDSS = $-10 \mu A (VDS = -30 V)$ N Channel IDSS = $10 \mu A (VDS = 30 V)$

Enhancement-mode

: P Channel $V_{th} = -0.8 \text{ to } -2.0 \text{ V } (V_{DS} = -10 \text{ V}, I_D = -1 \text{ mA})$ N Channel $V_{th} = 1.3$ to 2.5 V ($V_{DS} = 10$ V, $I_{D} = 1$ mA)

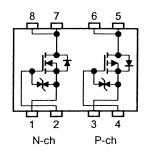
Absolute Maximum Ratings (Ta = 25°C)

С	Symbol		ting	Unit	
	•	P Channel	1		
Drain-source v	voltage	V_{DSS}	730	30	V
Drain-gate vol	tage ($R_{GS} = 20 \text{ k}\Omega$)	V_{DGR}	-30	> 30	/\v
Gate-source v	oltage	V _{GSS} /	±20	±20	>
Drain current	DC (Note 1)	_D	-4.5	6	A
Dialii Cuitelii	Pulse (Note 1)	(IDP)	-18	24 🔨	. ^
Drain power dissipation	Single-device operation (Note 3a)	PD (1)	1.5	1.5	
(t = 10s) (Note 2a)	Single-device value at dual operation (Note 3b)	P _D (2)	1.1	1.1	> w
Drain power dissipation	Single-device operation (Note 3a)	P _{D (1)}	0.75	0.75	VV
(t = 10s) (Note 2b)	Single-device value at dual operation (Note 3b)	P _{D (2)}	0.45	0.45	
Single pulse a	Eas	13.2 (Note 4a)	23.4 (Note 4b)	mJ	
Avalanche cur	JAR (-4.5	6	Α	
Repetitive ava Single-device	EAR	> 0	.1	mJ	
Channel temp	Teh	15	50	°C	
Storage tempe	T _{stg}	−55 t	o 150	°C	



Weight: 0.080 g (typ.)

Circuit Configuration



Note: For Notes 1 to 5, refer to the next page.

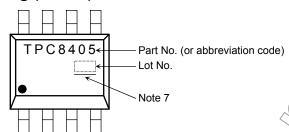
Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

This transistor is an electrostatic-sensitive device. Handle with care.

Thermal Characteristics

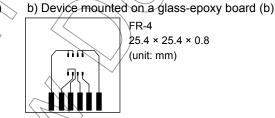
Characteristics	Symbol	Max	Unit	
The second residence of constant	Single-device operation (Note 3a)	R _{th (ch-a) (1)}	83.3	
Thermal resistance, channel to ambient (t = 10s) (Note 2a)	Single-device value at dual operation (Note 3b)	R _{th} (ch-a) (2)	114	
Thermal registance, channel to ambient	Single-device operation (Note 3a)	R _{th (ch-a) (1)}	167	°C/W
Thermal resistance, channel to ambient (t = 10s) (Note 2b)	Single-device value at dual operation (Note 3b)	R _{th} (ch-a) (2)	278	

Marking (Note 6)



Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2: a) Device mounted on a glass-epoxy board (a)



(b)

FR-4 25.4 × 25.4 × 0.8 (unit: mm)

(a)

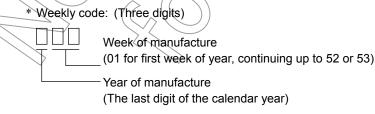
Note 3: a) The power dissipation and thermal resistance values shown are for a single device. (During single-device operation, power is applied to one device only.)

b) The power dissipation and thermal resistance values shown are for a single device. (During dual operation, power is evenly applied to both devices.)

Note 4: a) $V_{DD}=24$ V, $T_{Ch}=25^{\circ}\text{C}$ (initial), L=0.5 mH, $R_{G}=25$ Ω , $I_{AR}=-4.5$ A b) $V_{DD}=24$ V, $T_{Ch}=25^{\circ}\text{C}$ (initial), L=0.5 mH, $R_{G}=25$ Ω , $I_{AR}=6.0$ A

Note 5: Repetitive rating: pulse width limited by maximum channel temperature

Note 6: • on the lower left of the marking indicates Pin 1.



Note 7: A line under a Lot No. identifies the indication of product Labels.

Not underlined: [[Pb]]/INCLUDES > MCV

Underlined: [[G]]/RoHS COMPATIBLE or [[G]]/RoHS [[Pb]]

Please contact your TOSHIBA sales representative for details as to environmental matters such as the RoHS compatibility of Product. The RoHS is the Directive 2002/95/EC of the European Parliament and of the Council of 27 January 2003 on the restriction of the use of certain hazardous substances in electrical and electronic equipment.

P-ch

Electrical Characteristics (Ta = 25°C)

Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current		I _{GSS}	V _{GS} = ±16 V, V _{DS} = 0 V	_	_	±10	μΑ
Drain cut-OFF of	current	I _{DSS}	V _{DS} = -30 V, V _{GS} = 0 V	Á	_	-10	μΑ
Drain-source bro	eakdown	V _{(BR) DSS}	I_D = -10 mA, V_{GS} = 0 V	(-30	4	1	V
voltage		V _{(BR) DSX}	I _D = -10 mA, V _{GS} = 20 V	15)) –		V
Gate threshold	voltage	V_{th}	V _{DS} = -10 V, I _D = -1 mA	8.0	_	-2.0	٧
Drain-source Of	N resistance	R _{DS} (ON)	V _{GS} = -4.5 V, I _D = -2.2 A	<u> </u>	32	42	mΩ
Dialii-Source Of	v resistance	R _{DS} (ON)	V _{GS} = -10 V, I _D = -2.2 A	· –	25	33	mΩ
Forward transfe	r admittance	Y _{fs}	V _{DS} = -10 V, I _D = -2.2 A	6	12	_	S
Input capacitance		C _{iss}	2(>>	_	1540	7	
Reverse transfer capacitance		C _{rss}	$V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	- (220		pF
Output capacitance		Coss		-((250	(–	
Switching time	Rise time	t _r	V_{GS} $0 V$ $I_{D} = -2.2 A$ V_{OUT}		50) _	
	Turn-ON time	t _{on}		\bigcirc	13	_	
	Fall time	t _f	6.80) –	35	_	ns
	Turn-OFF time	t _{off}	$\begin{array}{c} V_{DD} = -15 \text{ V} \\ \text{Duty} \leq 1\%, \text{ t}_{\mathbf{w}} = 10 \mu\text{s} \end{array}$	_	125	_	
Total gate charge (Gate-source plus gate-drain)		Qg			40		
Gate-source charge 1		Qgs1	$V_{DD} \approx -24 \text{ V}, V_{GS} = -10 \text{ V}, I_D = -4.5 \text{ A}$	_	4.4	_	nC
Gate-drain ("miller") charge		Qgd		_	8.2	_	

Source-Drain Ratings and Characteristics (7a = 25°C)

Characteristics Symbol Test Condition	Min	Тур.	Max	Unit
Drain reverse current Rulse (Note 1) I _{DRP} —	_	_	-18	А
Forward voltage (diode) V _{DSF} I _{DR} = -4.5 A, V _{GS} = 0 V	_	_	1.2	V

N-ch

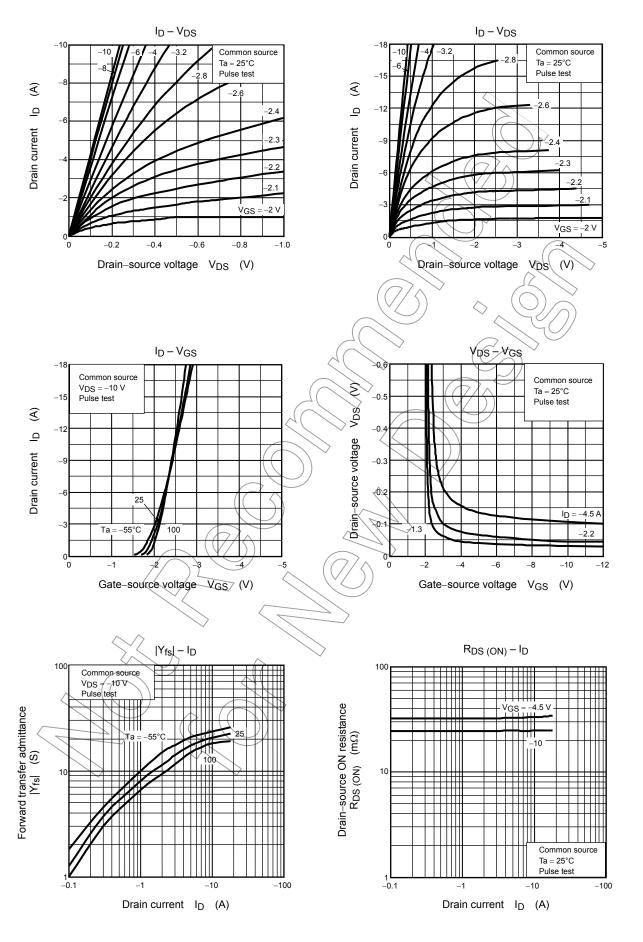
Electrical Characteristics (Ta = 25°C)

Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current		I _{GSS}	V _{GS} = ±16 V, V _{DS} = 0 V	_	_	±10	μΑ
Drain cut-OFF current		I _{DSS}	V _{DS} = 30 V, V _{GS} = 0 V	Á		10	μΑ
Drain-source breakdown		V _{(BR) DSS}	I _D = 10 mA, V _{GS} = 0 V	(30	12	_	V
voltage		V _{(BR) DSX}	I _D = 10 mA, V _{GS} = -20 V) 5) <u> </u>	_	V
Gate threshold	voltage	V_{th}	V _{DS} = 10 V, I _D = 1 mA	1.3	_	2.5	٧
Drain-source Of	N recistance	R _{DS} (ON)	V _{GS} = 4.5 V, I _D = 3 A		25	33	mΩ
Dialii-source Of	v resistance	R _{DS} (ON)	V _{GS} = 10 V, I _D = 3 A	<u> </u>	20	26	11122
Forward transfer admittance		Y _{fs}	V _{DS} = 10 V, I _D = 3 A	7	14	_	S
Input capacitano	Input capacitance		4(>>	1	1240	\ <u></u>	
Reverse transfer capacitance		C _{rss}	V _{DS} = 10 V, V _{GS} = 0 V f = 1 MHz	-	180	_	pF
Output capacitance		Coss	$(\checkmark / 5)$	+	230	_	
Switching time	Rise time	t _r	V_{GS} $_{0}$ V_{OUT}		4.5	_	
	Turn-ON time	t _{on}	VOUT RL = 5.0 \Omega)	(2)	12.5	_	no
	Fall time	t _f	A m m) –	6.6	_	ns
	Turn-OFF time	t _{off}	Duty \leq 1%, $t_{\rm w} = 10 \mu{\rm s}$	_	33	_	
Total gate charge (Gate-source plus gate-drain)		Qg		_	27	_	
Gate-source charge 1		Q _{gs1}	$V_{DD} \approx 24 \text{ V}, V_{GS} = 10 \text{ V}, V_{D} = 6 \text{ A}$	_	3.9	_	nC
Gate-drain ("miller") charge		Qgd		_	7.0	_	

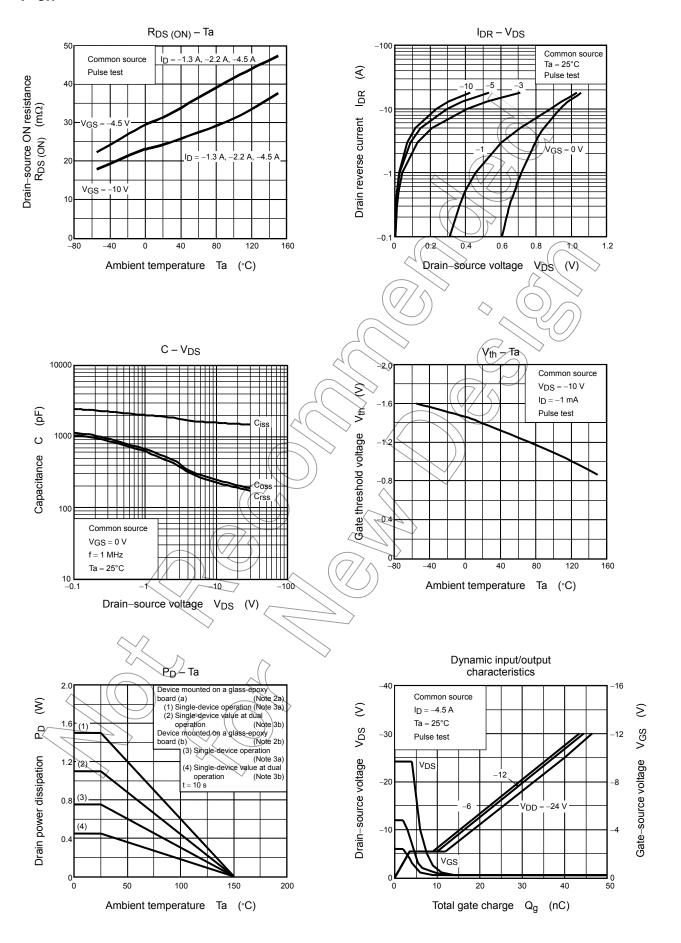
Source-Drain Ratings and Characteristics (Ta = 25°C)

Characteristics Symbol Test Condition	Min	Тур.	Max	Unit
Drain reverse current Pulse (Note 1) I _{DRP} —	_	_	24	Α
Forward voltage (diode) V _{DSF} I _{DR} = 6 A, V _{GS} = 0 V	_	_	-1.2	V

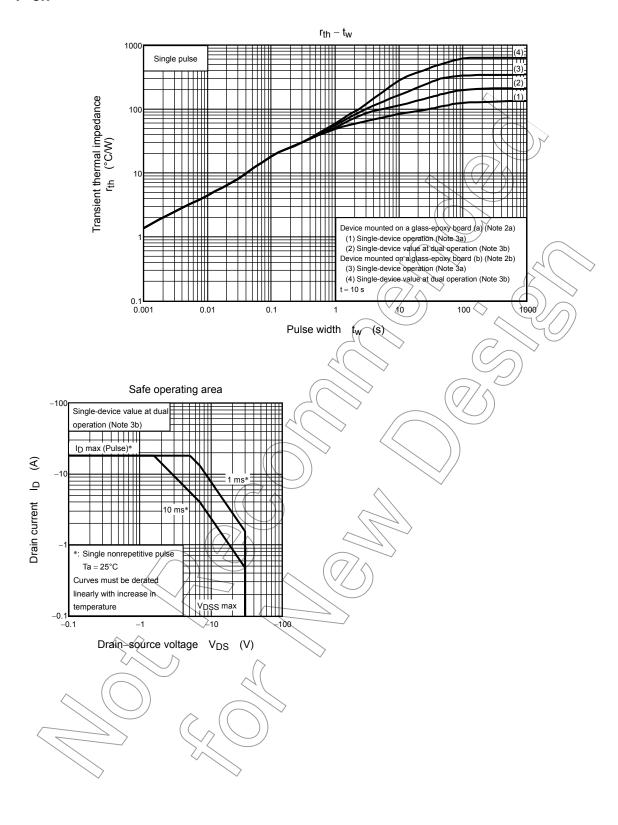
P-ch



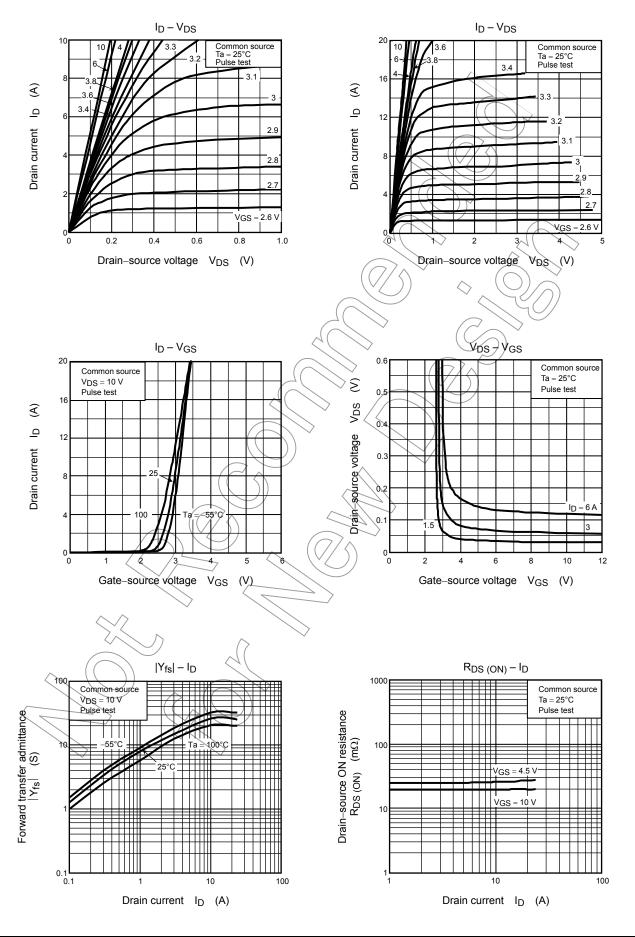
P-ch



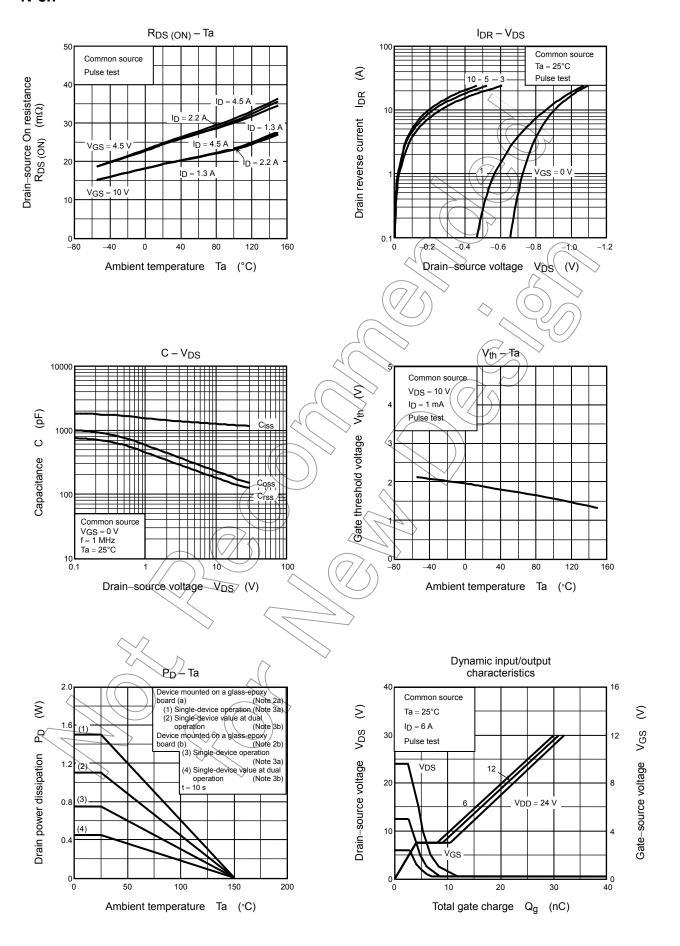
P-ch



N-ch

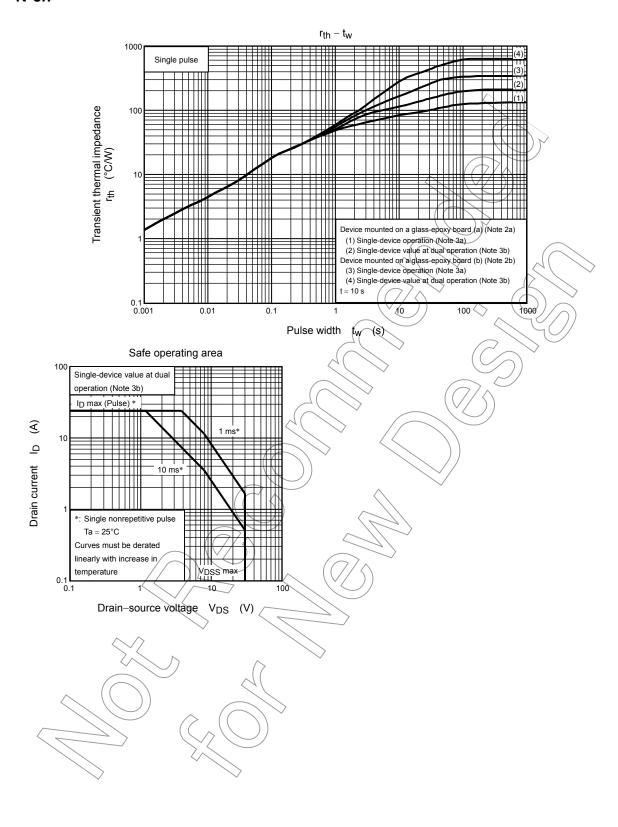


N-ch



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N-ch



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